

## BUK453-50A-VB Datasheet N-Channel 60 V(D-S) MOSFET

| PRODUCT SUMMARY          |                              |    |  |  |  |
|--------------------------|------------------------------|----|--|--|--|
| V <sub>DS</sub> (V)      | 60                           |    |  |  |  |
| R <sub>DS(on)</sub> (Ω)  | V <sub>GS</sub> = 10 V 0.072 |    |  |  |  |
| Q <sub>g</sub> max. (nC) | 25                           |    |  |  |  |
| Q <sub>gs</sub> (nC)     | 5.8                          |    |  |  |  |
| Q <sub>gd</sub> (nC)     | 11                           |    |  |  |  |
| Configuration            | Sing                         | le |  |  |  |

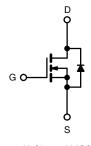
## FEATURES

- Dynamic dV/dt rating
- · Fast switching
- Ease of paralleling

Simple drive requirements







N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>                                                     | = 25 °C, unl            | ess otherwis                                                              | se noted)       |      |          |  |
|----------------------------------------------------------------------------------------------|-------------------------|---------------------------------------------------------------------------|-----------------|------|----------|--|
| PARAMETER                                                                                    |                         | SYMBOL                                                                    | LIMIT           | UNIT |          |  |
| Drain-Source Voltage                                                                         |                         | V <sub>DS</sub>                                                           | 60              | V    |          |  |
| Gate-Source Voltage                                                                          |                         |                                                                           | V <sub>GS</sub> | ± 20 | V        |  |
| Continuous Drain Current                                                                     | V at 10 V               | $T_{\rm C} = 25 \ ^{\circ}{\rm C}$<br>$T_{\rm C} = 100 \ ^{\circ}{\rm C}$ | I               | 20   |          |  |
|                                                                                              | V <sub>GS</sub> at 10 V | T <sub>C</sub> = 100 °C                                                   | ID              | 12   | А        |  |
| Pulsed Drain Current <sup>a</sup>                                                            |                         |                                                                           | I <sub>DM</sub> | 68   |          |  |
| Linear Derating Factor                                                                       |                         |                                                                           |                 | 0.40 | W/°C     |  |
| Single Pulse Avalanche Energy <sup>b</sup>                                                   |                         |                                                                           | E <sub>AS</sub> | 100  | mJ       |  |
| Maximum Power Dissipation                                                                    | T <sub>C</sub> = 25 °C  |                                                                           | PD              | 60   | W        |  |
| Peak Diode Recovery dV/dt <sup>c</sup>                                                       |                         |                                                                           | dV/dt           | 4.5  | V/ns     |  |
| erating Junction and Storage Temperature Range T <sub>J</sub> , T <sub>stg</sub> -55 to +175 |                         | -55 to +175                                                               | °C              |      |          |  |
| Soldering Recommendations (Peak temperature) <sup>d</sup>                                    | for                     | 10 s                                                                      |                 | 300  |          |  |
| Mounting Torque                                                                              | 6-32 or M3 screw        |                                                                           |                 | 10   | lbf ∙ in |  |
| Mounting Torque                                                                              |                         |                                                                           |                 | 1.1  | N · m    |  |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 403 µH,  $R_g = 25 \Omega$ ,  $I_{AS} = 17 \text{ A}$  (see fig. 12).
- c.  $I_{SD} \le 17$  A, dl/dt  $\le 140$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175$  °C.
- d. 1.6 mm from case.

## BUK453-50A-VB



| THERMAL RESISTANCE RAT              | HERMAL RESISTANCE RATINGS |      |      |      |
|-------------------------------------|---------------------------|------|------|------|
| PARAMETER                           | SYMBOL                    | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient         | R <sub>thJA</sub>         | -    | 62   |      |
| Case-to-Sink, Flat, Greased Surface | R <sub>thCS</sub>         | 0.50 | -    | °C/W |
| Maximum Junction-to-Case (Drain)    | R <sub>thJC</sub>         | -    | 2.5  |      |

| PARAMETER                                 | SYMBOL              | TES                                                                          | T CONDITIONS                                                                     | MIN.      | TYP.                 | MAX.             | UNIT |
|-------------------------------------------|---------------------|------------------------------------------------------------------------------|----------------------------------------------------------------------------------|-----------|----------------------|------------------|------|
| Static                                    |                     |                                                                              |                                                                                  |           | •                    |                  |      |
| Drain-Source Breakdown Voltage            | V <sub>DS</sub>     | V <sub>GS</sub> =                                                            | = 0 V, I <sub>D</sub> = 250 μΑ                                                   | 60        | -                    | -                | V    |
| V <sub>DS</sub> Temperature Coefficient   | $\Delta V_{DS}/T_J$ | Referenc                                                                     | e to 25 °C, I <sub>D</sub> = 1 mA                                                | -         | 0.061                | -                | V/°C |
| Gate-Source Threshold Voltage             | V <sub>GS(th)</sub> | V <sub>DS</sub> =                                                            | : V <sub>GS</sub> , I <sub>D</sub> = 250 μA                                      | 1.0       | -                    | 3.0              | V    |
| Gate-Source Leakage                       | I <sub>GSS</sub>    |                                                                              | V <sub>GS</sub> = ± 20 V                                                         | -         | -                    | ± 100            | nA   |
| Zero Gate Voltage Drain Current           | I <sub>DSS</sub>    |                                                                              | = 60 V, V <sub>GS</sub> = 0 V<br>V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C  | -         |                      | 25<br>250        | μA   |
| Drain-Source On-State Resistance          | R <sub>DS(on)</sub> | V <sub>GS</sub> = 10 V                                                       |                                                                                  | -         | 0.072                | -                | Ω    |
| Forward Transconductance                  | 9 <sub>fs</sub>     |                                                                              | = 25 V, I <sub>D</sub> = 10 A                                                    | 5.5       | -                    | -                | S    |
| Dynamic                                   |                     |                                                                              |                                                                                  | 1         |                      | <u> </u>         | 1    |
| Input Capacitance                         | C <sub>iss</sub>    | $V_{GS} = 0 V,$                                                              |                                                                                  | -         | 640                  | -                | pF   |
| Output Capacitance                        | C <sub>oss</sub>    |                                                                              | $V_{DS} = 25 V,$                                                                 |           | 360                  | -                |      |
| Reverse Transfer Capacitance              | C <sub>rss</sub>    | f = 1.0 MHz, see fig. 5                                                      |                                                                                  | -         | 79                   | -                |      |
| Total Gate Charge                         | Qg                  |                                                                              | I <sub>D</sub> = 17 A, V <sub>DS</sub> = 48 V,<br>see fig. 6 and 13 <sup>b</sup> | -         | -                    | 25               | nC   |
| Gate-Source Charge                        | Q <sub>gs</sub>     | V <sub>GS</sub> = 10 V                                                       |                                                                                  | -         | -                    | 5.8              |      |
| Gate-Drain Charge                         | Q <sub>gd</sub>     |                                                                              |                                                                                  | -         | -                    | 11               |      |
| Turn-On Delay Time                        | t <sub>d(on)</sub>  |                                                                              |                                                                                  | -         | 13                   | -                |      |
| Rise Time                                 | t <sub>r</sub>      | -<br>V:                                                                      | V <sub>DD</sub> = 30 V, I <sub>D</sub> = 17 A,                                   |           | 58                   | -                | ns   |
| Turn-Off Delay Time                       | t <sub>d(off)</sub> | $R_g$ = 18 $\Omega$ , $R_D$ = 1.7 $\Omega$ , see fig. 10 <sup>b</sup>        |                                                                                  | -         | 25                   | -                |      |
| Fall Time                                 | t <sub>f</sub>      |                                                                              |                                                                                  | -         | 42                   | -                |      |
| Internal Drain Inductance                 | L <sub>D</sub>      | 6 mm (0.25") f                                                               | Between lead,<br>6 mm (0.25") from                                               |           | 4.5                  | -                |      |
| Internal Source Inductance                | L <sub>S</sub>      | die contact                                                                  |                                                                                  | -         | 7.5                  | -                | - nH |
| Drain-Source Body Diode Characteristic    | s                   |                                                                              |                                                                                  |           | •                    |                  |      |
| Continuous Source-Drain Diode Current     | I <sub>S</sub>      | MOSFET symbol<br>showing the                                                 |                                                                                  | -         | -                    | 20               | Α    |
| Pulsed Diode Forward Current <sup>a</sup> | I <sub>SM</sub>     | integral revers<br>p - n junction                                            |                                                                                  | -         | -                    | 68               |      |
| Body Diode Voltage                        | V <sub>SD</sub>     | T <sub>J</sub> = 25 °C                                                       | , $I_{\rm S}$ = 17 A, $V_{\rm GS}$ = 0 V <sup>b</sup>                            | -         | -                    | 1.5              | V    |
| Body Diode Reverse Recovery Time          | t <sub>rr</sub>     | $T_J = 25 \text{ °C}, I_F = 17 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}$ |                                                                                  | -         | 88                   | 180              | ns   |
| Body Diode Reverse Recovery Charge        | Q <sub>rr</sub>     |                                                                              |                                                                                  | -         | 0.29                 | 0.64             | μC   |
| Forward Turn-On Time                      | t <sub>on</sub>     | Intrinsic tu                                                                 | -on is doi                                                                       | minated b | y L <sub>S</sub> and | L <sub>D</sub> ) |      |

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

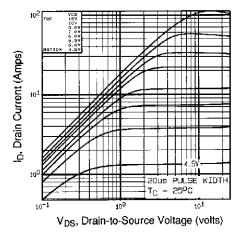


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C



Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 175 °C

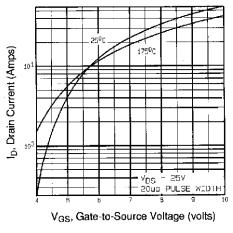


Fig. 3 - Typical Transfer Characteristics

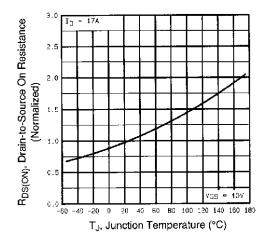


Fig. 4 - Normalized On-Resistance vs. Temperature

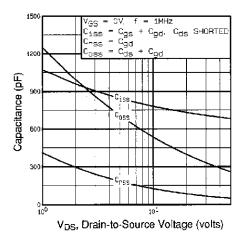


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

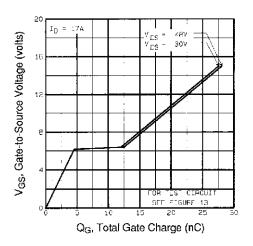


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



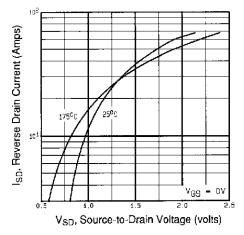


Fig. 7 - Typical Source-Drain Diode Forward Voltage

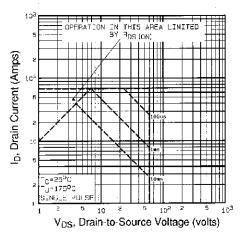


Fig. 8 - Maximum Safe Operating Area

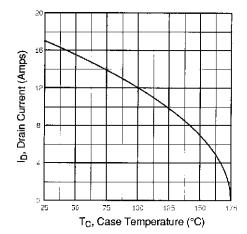


Fig. 9 - Maximum Drain Current vs. Case Temperature

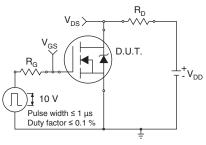


Fig. 10a - Switching Time Test Circuit

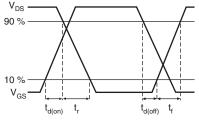
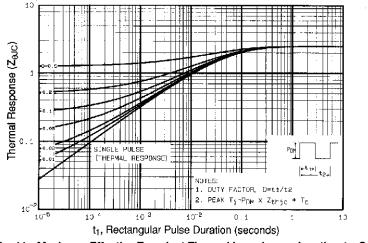


Fig. 10b - Switching Time Waveforms







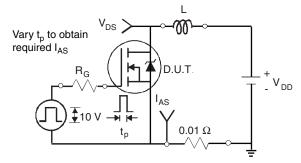


Fig. 12a - Unclamped Inductive Test Circuit

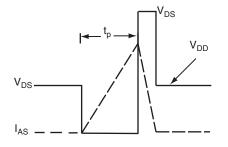


Fig. 12b - Unclamped Inductive Waveforms

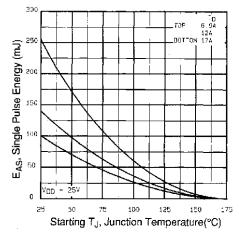


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

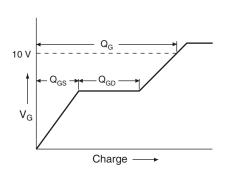


Fig. 13a - Basic Gate Charge Waveform

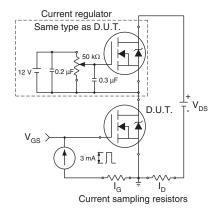
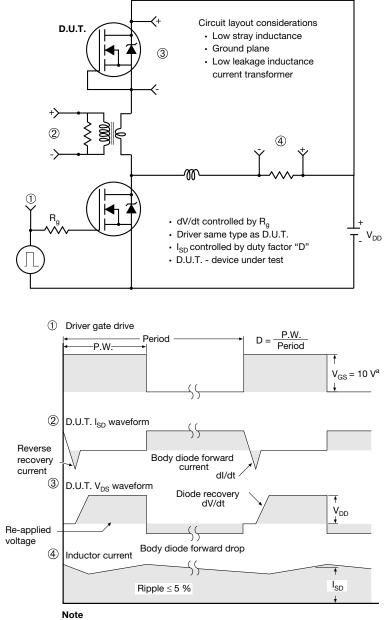


Fig. 13b - Gate Charge Test



Peak Diode Recovery dV/dt Test Circuit

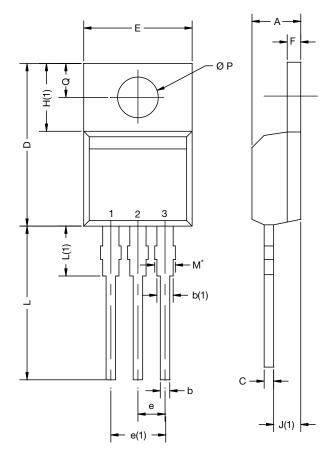


a.  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel



## TO-220



| DIM.                  | MILLIN            | IETERS    | INCHES |       |  |
|-----------------------|-------------------|-----------|--------|-------|--|
| DIM.                  | MIN.              | MAX.      | MIN.   | MAX.  |  |
| А                     | 4.24              | 4.65      | 0.167  | 0.183 |  |
| b                     | 0.69              | 1.02      | 0.027  | 0.040 |  |
| b(1)                  | 1.14              | 1.78      | 0.045  | 0.070 |  |
| С                     | 0.36              | 0.61      | 0.014  | 0.024 |  |
| D                     | 14.33             | 15.85     | 0.564  | 0.624 |  |
| Е                     | 9.96              | 10.52     | 0.392  | 0.414 |  |
| е                     | 2.41              | 2.67      | 0.095  | 0.105 |  |
| e(1)                  | 4.88              | 5.28      | 0.192  | 0.208 |  |
| F                     | 1.14              | 1.40      | 0.045  | 0.055 |  |
| H(1)                  | 6.10              | 6.71      | 0.240  | 0.264 |  |
| J(1)                  | 2.41              | 2.92      | 0.095  | 0.115 |  |
| L                     | 13.36             | 14.40     | 0.526  | 0.567 |  |
| L(1)                  | 3.33              | 4.04      | 0.131  | 0.159 |  |
| ØΡ                    | 3.53              | 3.94      | 0.139  | 0.155 |  |
| Q                     | 2.54              | 3.00      | 0.100  | 0.118 |  |
| ECN: X15-<br>DWG: 603 | 0364-Rev. C,<br>1 | 14-Dec-15 |        |       |  |

Note

-  $M^{\star}$  = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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